

Search Notes

Application/Control No.

10/736,720

Examiner

Eric B. Chen

Applicant(s)/Patent under
Reexamination

LEE, KEUN WOO

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search (PALM)	7/19/2005	EC
EAST (all databases) - see search history printout	7/20/2005	EC
438/690-692,700,702,706,710,719, 723,724,745,753,756,757,770,775 (text search only) (consulted K. Chen)	7/21/2005	EC
438/221,296,427,637; 438/369,370 (text search only) (consulted with K. Chen)	7/21/2005	EC